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U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
UH	AA	4,608,464	08/26/1986	Morikawa et al.	179	170.2	
	AB						
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	slation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
NOH	AL	PCT/DE00/00349	08/10/2000	WIPO	H04B	3/23, 1/58	Abst.	
No.	AM							
•	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner Initial	Desig. ID	Document		
	AQ			
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	AS	*		
	AT			

Examiper Signature	Date Considered					
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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with						
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